Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/066,545	TSIKOS ET AL.	
Examiner	Art Unit	
Thien M. Le	2876	

SEARCHED					
Class	Subclass	Date	Examiner		
235	462.01- 462.47				
	472.01				
	472.02				
	472.03				
	454				
	455				
	494	3/24/2003	LTM		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
235	462 AII				
	472 All	10/22/2005	LTM		

SEARCH I (INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR
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